

CE5184

PRODUCT DESCRIPTION

CE5184 provides the following product characteristics:

| Technology | Ероху |
|------------------|---|
| Appearance | Silver |
| Cure | Heat cure |
| рН | 6.0 |
| Product Benefits | Conductive |
| | Box oven cure |
| | Excellent dispensability, minimal |
| | tailing and stringing |
| Application | Die attach |

LONGAIN CE5184 electrically conductive die attach adhesive has been formulated for use in high throughput, automated die attach equipment. The rheology of LONGAIN CE5184 adhesive allows minimum adhesive dispense and die put downd well times, without tailing or stringing problems.

The unique combination of adhesive properties makes this material one of the most widely used die attach materials in the semiconductor industry.

TYPICAL PROPERTIES OF UNCURED MATERIAL

| Thixotropic Index (0.5/5 rpm) | 5.6 |
|---|-------|
| Viscosity, Brookfield CP51, 25 °C, mPa·s (cP): | |
| Speed 5 rpm | 8,000 |
| Work Life @ 25 °C, Physical worklife by % filler, hours | 18 |
| Shelf Life @ -40°C (from date of manufacture), days | 365 |
| Flash Point - See SDS | |

TYPICAL CURING PERFORMANCE

Cure Schedule

1 hour @ 175°C

Alternate Cure Schedule

3 to 5 minute ramp to $175^{\circ}\text{C} + 1$ hour @ $175^{\circ}\text{C}^{(1)}$

Weight Loss

| 10 x 10 mm Si die on glass slide, % | 5.3 |
|-------------------------------------|-----|
| | |

(1)The ramp was observed to yield reduced bondline voiding and increased strength.

The above cure profiles are guideline recommendations. Cure conditions (time and temperature) may vary based on customers' experience and their application requirements, as well as customer curing equipment, oven loading and actual oven temperatures.

TYPICAL PROPERTIES OF CURED MATERIAL

Physical Properties

| Glass | Transition | Temperature, | ΔNMT | nenetration | °C | 120 |
|-------|--------------|-----------------|--------------|---------------|----|-----|
| Glass | 114113111011 | i Cilipciatuic, | 11111 | perietiation, | _ | 120 |

| Coefficient of Thermal Expansion , TMA expansi | ansion: 40 150 |
|--|--|
| Thermal Conductivity @ 121°C, C-matic (Tester, W/(m-K) | Conductance 2.5 |
| Tensile Modulus, DMTA : | |
| @ -65 °C | N/mm ² 4,400 (psi) (640,000) |
| @ 25 °C | N/mm ² 3,900 (psi) (570,000) |
| @ 150 °C | N/mm ² 2,000 |
| @ 250 °C | (psi) (290,000) N/mm ² 300 (psi) (44,000) |
| Extractable Ionic Content @ 100 °C, ppm: | |
| Chloride (CI-) | <20 |
| Sodium (Na+) | <10 |
| Potassium (K+) | <10 |
| Water Extract Conductivity, mS/m | ≤2.0 |
| Weight Loss @ 300°C, TGA, % | 0.35 |
| Moisture Absorption @ Saturation, wt.%, | @ 85°C/85% 0.6 |

Electrical Properties

| Volume Resistivity, ohms-cm | ≤0.0002 |
|-----------------------------|---------|
|-----------------------------|---------|

TYPICAL PERFORMANCE OF CURED MATERIAL

Shear Strength

| Lap Shear Strength | N/mm² | 7.0 |
|---------------------|-------|-------|
| | (psi) | (995) |
| Die Shear Strength: | | |

2 X 2 mm (80 x 80 mil) Si die on Ag/Cu LF, Kg:

| | @ 25 °C | ≥8.0 |
|--------------|---------|------|
| @ 150°C ≥2.8 | _ | ≥2.8 |

3 X 3 mm (120 x 120 mil) Si die:

| Post Cure: | |
|---|------------------|
| On Ag/Cu LF, kg-f/die: @ 25 °C @ 200°C @ 250 °C | 21 2.9 1.7 |
| On Bare Cu LF, kg-f/die: @ 25 °C @ 200°C @ 250 °C | 11 2.6 1.4 |
| On Pd/Ni/Cu LF, kg-f/die: @ 25 °C @ 200°C @ 250 °C | 27 2.4 2.0 |

After 85°C/85% RH exposure for 168 hours:

| On A | g/Cu LF, kg-f/die: | |
|-------|-----------------------|-----|
| @ 2 | 25 °C | 12 |
| @ 2 | 200°C | 1.8 |
| On Ba | re Cu LF, kg-f/die: | |
| @ 2 | 25 °C | 10 |
| @ 2 | 200°C | 2.5 |
| On Po | I/Ni/Cu LF, kg-f/die: | |
| @ 2 | 25 °C | 23 |
| @ 2 | 200°C | 1.8 |

Miscellaneous

Chip Warpage vs Post Cure Thermal Process:

0.38 mm thick Si die on 0.2 mm thick Ag/Cu LF:

| 7.6 x 7.6 mm chip size, μm | 19 |
|--|----|
| 10.2 x 10.2 mm chip size, μm | 32 |
| 12.7 x 12.7 mm (500 x 500 mil) chip size, μm | 51 |

Chip Warpage vs Post Cure Thermal Process:

3 x 3 mm (120 x 120 mil) Si die:

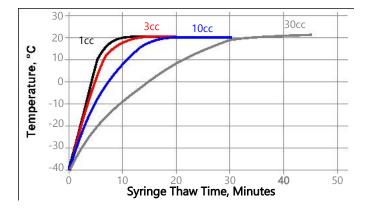
| Post Cure, µm: | |
|------------------------------------|----|
| On Ag/Cu LF | 20 |
| On Bare Cu LF | 22 |
| + Wirebond (1minute @ 250°C): | |
| On Ag/Cu LF | 29 |
| On Bare Cu LF | 30 |
| + Post Mold Bake (4hours @ 175°C): | |
| On Ag/Cu LF | 28 |
| On Bare Cu LF | 28 |

GENERAL INFORMATION

For safe handling information on this product, consult the Material Safety Data Sheet, (MSDS).

THAWING:

- 1. Allow container to reach room temperature before use.
- After removing from the freezer, set the syringes to stand vertically while thawing.
- DO NOT open the container before contents reach 25°C temperature. Any moisture that collects on the thawed container should be removed prior to opening the container.
- DO NOT re-freeze. Once thawed to 25°C, the adhesive should not be re-frozen.



DIRECTIONS FOR USE

- 1. Thawed adhesive should immediately be placed on dispense equipment for use.
- If the adhesive is transferred to a final dispensing reservoir, care must be exercised to avoid entrapment of contaminants and/or air into the adhesive.
- 3. Adhesive must be completely used within the product's recommended work life of 18 hours.
- 4. Silver-resin separation may occur if the adhesive is left out at 22 °C beyond the recommended work life.
- Apply enough adhesive to achieve a 25 to 50 μm wet bondline thickness, dispensed with approximately 25 to 50 % filleting on all sides of the die.
- 6. Alternate dispense amounts may be used depending on the application requirements.
- 7. Star or crossed shaped dispense patterns will yield fewer bondline voids than the matrix style of dispense pattern.

Not for product specifications

The technical data contained herein are intended as reference only. Please contact your local quality department for assistance and recommendations on specifications for this product.

Storage

Store product in the unopened container in a dry location. Storage information may be indicated on the product container labeling.

Optimal Storage: -40 °C. Storage below minus (-)40 °C or greater than minus (-)40 °C can adversely affect product properties.

Material removed from containers may be contaminated during use. Do not return product to the original container. Longain Corporation cannot assume responsibility for product which has been contaminated or stored under conditions other than those previously indicated. If additional information is required, please contact your local Technical Service Center or Customer Service Representative.

Conversions

(°C x 1.8) + 32 = °F kV/mm x 25.4 = V/mil mm / 25.4 = inches N x 0.225 = lb N/mm x 5.71 = lb/in N/mm² x 145 = psi MPa = N/mm² MPa x 145 = psi N·m x 8.851 = lb·in N·m x 0.738 = lb·ft N·mm x 0.142 = oz·in mPa·s = cP

Disclaimer

Note:

The information provided in this Technical Data Sheet (TDS) including the recommendations for use and application of the product are based on our knowledge and experience of the product as at the date of this TDS. The product can have a variety of different applications as well as differing application and working conditions in your environment that are beyond our control. Longain is, therefore, not liable for the suitability of our product for the production processes and conditions in respect of which you use them, as well as the intended applications and results. We strongly recommend that you carry out your own prior trials to confirm such suitability of our product.

Any liability in respect of the information in the Technical Data Sheet or any other written or oral recommendation(s) regarding the concerned product is excluded, except if otherwise explicitly agreed and except in relation to death or personal injury caused by our negligence and any liability under any applicable mandatory product liability law.